

## ENABLE PROPAGATION CONTROLLER

### Field of the Invention

5       The present invention relates, in general to Electronic Control  
Mechanisms designed for use in portable transceivers and, more particularly, to  
a timed warm-up and warm-down of analog and digital components in  
sequences that reduce power surges and consumption while also providing a  
mechanism for individually testing these analog and digital components during  
10 a test mode.

### Background of the Invention

Sequence Managers are widely used for controlling the sequencing and  
15 duration during runtime of components on mixed-mode (i.e. analog and digital)  
IC's, such as transceivers, used in portable devices. When the sequence  
manager receives a transmit/receive trigger, it enables various components for  
various durations according to a pre-programmed sequence in order to reduce  
power drain on the transceiver IC as a whole, allowing for reduced battery  
20 consumption and preventing component error due to noise spikes.

Additionally, sequence managers help reduce power surges caused by warm-up  
and warm-down of the various components that need to be enabled for a  
particular operation such as transmitting or receiving data.

Prior art sequence managers are designed to allow a minimum amount of  
25 control of the sequence process by allowing some control signals to be written  
into on-chip memory. These control signals allow the user to manipulate the  
duration between enabling some of the components or sub-blocks as well as

allow limited control over the enabling sequence order. To simplify the implementation, conventional sequence managers are developed with certain restrictions as to what the user can program in order to make sure sub-blocks are properly enabled.

5           Because of these limitations, testing of sub-blocks controlled by the sequence manager is cumbersome. A user cannot gain full control of an individual sub-block and must efficiently utilize the control signals to gain the best available testing conditions for any given sub-block. This requires extensive knowledge of all sub-blocks and their interactions. Additionally,  
10       even by optimizing the test conditions by properly programming the control signals, complete control of the on-chip components cannot be achieved because the sequence manager has built-in limitations on control flexibility. What is needed is a sequence manager that allows for testing individual sub-blocks and allows for complete individual control of the sub-blocks for testing  
15       purposes while also allowing for greater sequence management control during normal operation.

### Brief Description of the Drawings

20           FIG. 1 is a block diagram representing a conventional sequence manager.

          FIG. 2 is an example of a memory instruction written to the on-chip programmable memory that feeds the conventional sequence manager of FIG.  
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25           FIG. 3 is a timing diagram that demonstrates a possible enabling sequence caused by the sequence manager in accordance with programmed memory demonstrated in Figure 2.

FIG. 4 is a schematic diagram representing the invention according to one embodiment.

FIG. 5 demonstrates examples of enable and control bits written to the programmable memory and used by the enable propagation controller in accordance with the invention.

### Detailed Description of the Drawings

FIG. 1 is a block diagram of a conventional sequence manager in a mixed-mode device, such as a transceiver. The mixed mode system **100** includes a sequence manager ("SM") **110**, a programmable memory **120** and a plurality of mixed-mode sub-blocks **130** that can be either analog or digital sub-components. The mixed-mode sub-blocks **130** typically include transmitting components TX1...TXN **140** and receiving components RX1...RXN **150** generally implemented in a transceiver IC device such as band-pass filters, limiters, low noise amplifiers, and etc.

Sequence Manager ("SM") **110** receives a reference clock signal **160** and a trigger signal **170**. Upon receiving the trigger signal **170**, the sequence manager produces a sequence of enable signals ENTX1...ENTXN and ENRX1...ENRXN **180**, each corresponding to and enabling their corresponding sub-block **130**. The majority of the sequence, timing and duration of the enable signals produced by SM **110** are predetermined by hard wired SM **110** logic (not shown) along with some variable programming provided by control signals **190** stored in the programmable memory **120**. The programmable memory **120** usually resides on the mixed mode system **100** with the sequence manager **110** and the various analog and digital sub-blocks **130**.

The programmable memory **120** allows a user employing the transceiver IC device to write limited instructions to the memory for controlling the sequence manager. These instructions typically are written to the memory through an interface such as a serially programmable interface ("SPI").

5 Conventional designs allow for a Transmit Enable ("Txen") **191**, a Receive Enable ("Rxen") **192**, a plurality of sequence duration control signals ("SD1...SDN") **193**, and a plurality of sequence order control signals ("SO1...SON") **194**. Txen **191** allows the user to control when the transceiver IC device should transmit; Rxen **192** allows the user to control when the transceiver IC device should receive; while SD1...SDN **193** and SO1...SDN **194** allow the user to control, on a limited basis, the duration for a predetermined sub-block should be enabled and the enabling or disabling sequence of predetermined sub-blocks, respectively. Because of sheer quantity and potential variation in how many sub-blocks **130** are implemented on the transceiver IC device **100**, the logic required in the sequence manager to allow for complete control of the sequence and duration of the sub-blocks is prohibitive. This is understood by imagining the complexity of allowing a user to write control sequences for a large finite number of intervals, such as N, requiring at least 2N number of logic components. As sub-blocks and/or allowed intervals increase, the size of the sequence manager becomes prohibitively expensive and power consumption increases. Consequently, every sequence manager is designed to allow just limited amount of sequence and duration control by the user through the control signals contained in the memory **120**.

25 The SM **110**, when it receives a trigger signal **170** determines whether either Txen **191** or Rxen **192** control bit is set to an ON state, represented by a logical "1" in this example. If Txen is set to "1", the SM **110** utilizing the hardwired internal control logic along with the limited amount of control

variation allowed through the control bits SD1...SDN **193** and SO1...SDN **194** provides enable signals ENTX1...ENTXN **181** to sequentially enable all transmit sub-blocks TX1...TXN **140** in a predetermined sequence and duration. Because all transmit sub-blocks **140** associated with a general Transmit control signal **191** are required to be enabled at some point in the transmit sequence (each having been hard-wired to be enabled if Txen **191** is a logical "1"), there is no mechanism for a user to enable or disable a single transmit sub-block **141**. This limitation makes it very onerous for designers of individual sub-block components of the transceiver IC device to test the sub-block they are responsible for testing. If a designer for Sub-block TX1 **141** wishes to test this sub-block, he would need to replace the sequence manager with a hardwired solution specifically designed to test the individual sub-block. Because the Sequence Manager and the sub-blocks are often located on a single transceiver IC device that is very small, providing the hard-wired logic required to test an individual sub-block is very difficult and expensive. Alternatively, a designer specializing in the circuitry of sub-block TX1 **141** would be required to understand the interplay and workings of each of the other sub-blocks TX2...TXN **142** with sub-block TX1 **141**.

Fig. 2 shows an example of an instruction written to memory **120** through a SPI or other interface while Fig. 3 shows a corresponding timing diagram of various enable signals **181** after the SM **110** receives an activating trigger **170**. In Fig. 2, the instruction **210** written to memory contains a transmit control bit **220**, a receive control bit **230**, a plurality of sequence duration control bits **240**, and a plurality of sequence ordering bits **250**. In this example, the transmit bit **220** is turned on, while the receive bit is disabled **230**. The duration control bits in this example SM **110** allow the user to program whether TX1 is enabled for a first duration or a second duration where the first duration and the second

duration vary by a predetermined amount. Additionally, the SO control bits SO1...SON in this example allow the user employing the transceiver IC device to program whether sub-block TXN is enabled before TX3. As the specific bit sequence used to control the duration and order are arbitrary based on the design logic hardwired in the SM 110, they are not specifically shown. Rather, it is to be understood for this example that the user has written an instruction informing TX1 to be enabled for a predefined and allowable duration and that sub-block TXN is to be enabled before TX3.

Accordingly, upon the SM 110 receiving a trigger signal 170 at time t0 of Fig. 3, the SM 110 executes a transmission sequence according to the control bits contained in memory. Accordingly, SM 110 begins enabling transmission sub-blocks sequentially based on the predetermined hardwired logic embedded in the SM 110. In this case, Sub-block TX1 is enabled at time T1, sub-block TX2 is enabled some time later at T2, where T2-T1 is controlled by the SM 110. Similarly, TX3 is enabled at T4, sometime after TXN was enabled because the instruction written to memory required TXN to be enabled before TX3. For some duration, from time T4 to time T6, all transmission sub-blocks are enabled allowing the transceiver to transmit according to its design specifications. This duration although functional during the normal operation of a transceiver device inhibits individual sub-block testing making it extremely cumbersome for a designer to individually toggle or control the sub-block for testing the sub-block's integrity. Assume for illustration only that the transmission is complete at time t5. After the transmission is complete, the trigger 170 is disabled and the SM 110 disables in a predetermined sequence each of the transmission sub-blocks 140, and the SM rests until receiving another trigger signal.

Fig. 4 is a block diagram of one embodiment according to the invention.

In this embodiment, a transceiver mixed-mode IC device **400** includes a programmable memory **410**, an enable propagation controller ("EPC") **420** and a plurality of digital and/or analog transmission and reception sub-blocks **430**.

5 In addition to allowing the user employing the transceiver IC device **400** to write Rx **415**, Tx **416**, and some sequence duration and order control SD1...SDN **417** and SO1...SON **418** respectively, the invention also allows a user to provide on or off enable signals ENTX1...ENTXN **411** and ENRX1...ENRXN **412**, each corresponding to a respective sub block  
10 TX1...TXN **431** or RX1...RXN **432**, and a control bit SMEN/EPC' **419** for determining whether the EPC **420** is in a first or sequence manager mode or a second or enable propagation mode. The sequence manager mode allows the EPC **420** to function like a conventional sequence manager with the added control of the user being able to control whether each individual sub-block will  
15 or will not be enabled during a predetermined enabling sequence, while the enable propagation mode causes the EPC **420** to essentially become transparent, allowing each and every one of the memory enable signals **413**, whether in an ON or OFF state, to pass through to their individual respective sub-blocks.

Enable propagation controller **420** includes a state machine **421** (or other  
20 control logic) and a plurality of logic gates such as logic gates **422 - 425**. The state machine **421** receives a reference clock signal **426**, a trigger signal **427**, and the control signals from the programmed memory **415-419**. The EPC **420** produces signals **428** that control whether, at what time and for what duration the logic gates such as logic gates **422 - 425** allow their received memory  
25 programmed enable signal inputs to pass through to their respective sub-blocks **430**. A logic gate is "activated" when the enable signal it receives is allowed to pass through to its desired destination. If the state machine or control logic (or

other control logic) **421** receives a control signal indicating that the EPC **420** is to operate in a sequence manager mode, i.e. SMEN/EPC' is a logical "1", then the state machine **421** allows all logic gates such as gates **422-425** to pass through their respective programmed enable input signals in a sequence and for a duration that has been predetermined and hard-wired into the state machine, allowing some limited control through control bits **417** and **418**. Although the EPC **420** provides the same capability as conventional sequence managers during a sequence manager mode operation, it further provides the flexibility that a user may program individual or combinations of memory enables **413** to not enable a corresponding sub-block when the state machine **421** causes the enable signal to pass through according to the sub-block's predetermined sequence and duration. To operate in the limited fashion of a conventional sequence manager, a user would write all logical ones to the enable memory bits **413** and write a logical one to the SMEN/EPC' control bit. Although logical ones represent an on state in this example, it should be noted that any logical scheme is contemplated.

Alternatively, if the state machine **421** receives a control signal indicating that the EPC **420** is to operate in an enable propagation or transparent mode, i.e. SMEN/EPC' is a logical "0", then the state machine forces all logic gates such as gates **422-425** to pass through their respective enable input signals regardless of timing and control signals stored in memory. In this mode, the invention allows a user to control each sub-block at his own discretion directly through programmable memory without worrying about built-in sequence and duration limitations associated with the sequence manager mode. This mode provides two distinct benefits. First, it allows the creation of custom sequences differing from those dedicated by the hardware in sequence manager mode. This is accomplished by configuring the EPC in transparent mode, and programming



the memory locations corresponding to ENTX1...ENTXN for transmit or ENRX1...ENRXN for receive in a desired order with desired durations between them. This feature allows the user to experiment and optimize the sequences for best operation. Secondly, this mode allows complete control for a designer to test his individually designed sub-block removing any need for knowledge of other sub-blocks removing the necessity for creating new testing sequence and duration logic control conventionally required during testing trials.

Fig. 5 demonstrates two instructions written to memory. In the first instruction **510**, SMEN/EPC' is programmed to a logical "1" putting the EPC 420 into a sequence manager mode. However, because the invention's sequence manager mode allows individual enable bits to be controlled, a designer may decide to not enable sub-block RX3 for instance. Accordingly, ENRX3 could be initially programmed to "0". The clock may then be stopped after a warm-up sequence so that all other receiving devices are enabled and the RX3 can be toggled on and off so its characteristics can be accurately observed. Of course, the reference clock can be programmed to self-gate after warm up such that once warm-up is complete, but before the trigger is removed indicating the commencement of a warm-down, the EPC's clock is stopped to reduce noise generation during actual data transmission or reception.

A second instruction **520** is demonstrated where the EPC **420** is instructed to be in a transparent mode, i.e. SMEN/EPC' is programmed to a logical "0". In this case, the control bits TX, RX, SD and SO have no effect because the state machine substantially simultaneously forces each of the logic gates to allow their respective signals to pass through. In this case, a designer can manipulate any sub-block individually or in groups as desired to fully test his sub-block. This is accomplished by simply changing the logical value of

the enable signals stored in the programmable memory. As this mode is generally used only in testing environments where power consumption is not an issue, enabling all sub-blocks or any combination of sub-blocks is not problematic.

5           It should be appreciated that an enable propagation controller has been disclosed that provides a mechanism for easily testing individual sub-blocks controlled by the enable propagation controller.

10           In the foregoing specification the invention has been described with reference to specific exemplary embodiments thereof. It will, however, be evident that various modifications and changes may be made thereto without departing from the broader spirit and scope of the invention. For example, the present invention may be used with sub-modules are not mixed modes, and could be similar sub-blocks and other logic combination can be used in place of logic shown. The specification and drawings are, accordingly, to be regarded in  
15           an illustrative rather than restrictive sense. Moreover, the following claims indicate the scope of the invention, and all variations that come within the meaning and range of equivalency of the claims are to be embraced within their scope.

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